



# Metal thin film chip resistors (the highest precision)

## ■ RG series

AEC-Q200 Compliant

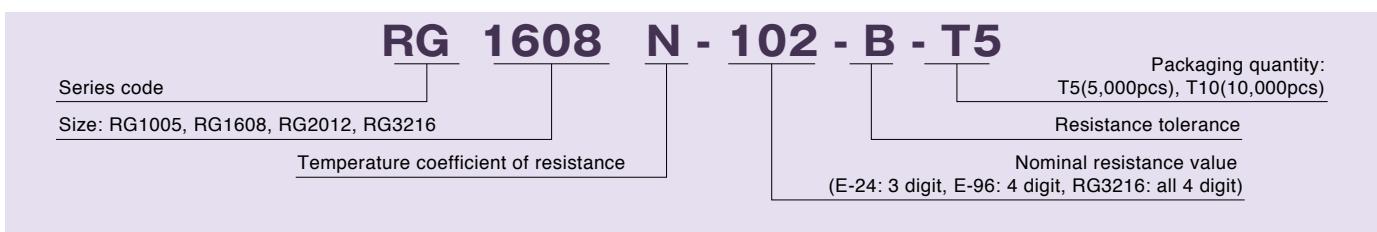
### Features

- Long term stability with inorganic passivation
- Less than  $\pm 0.1\%$  drift after 10000 hours of reliability test
- High precision resistance tolerance:  $\pm 0.05\%$ , very small TCR:  $\pm 5\text{ppm}/^\circ\text{C}$
- Thin film structure enabling low noise and anti-sulfur

### Applications

- Automotive electronics
- Industrial measurement instrumentation, industrial machines
- Various sensors, medical electronics

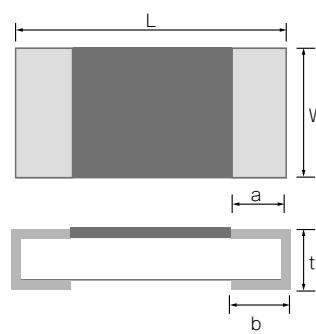
### ◆ Part numbering system



### ◆ Electrical Specification

Type	Power ratings			Temperature coefficient of resistance (ppm/ $^\circ\text{C}$ )	Resistance range ( $\Omega$ )				Resistance tolerance (%)	Maximum voltage	Resistance value series	Operating temperature	Pakaging quantity				
	Low	Regular	High		$\pm 0.02\%$ (P)	$\pm 0.05\%$ (W)	$\pm 0.1\%$ (B)	$\pm 0.5\%$ (D)									
RG1005	1/32W	1/16W	1/8W	$\pm 5(V)$	$100 \leq R < 3k$				75V	T5 T10	E-24, E-96 $-55^\circ\text{C}$ $\sim 155^\circ\text{C}$	T5 T10					
				$\pm 10(N)$	$100 \leq R < 3k$	$47 \leq R < 100k$											
				$\pm 25(P)$	$100 \leq R < 3k$	$47 \leq R < 100k$		$47 \leq R < 150k$									
				$\pm 100(R)$	—	—	—	$10 \leq R < 47$									
RG1608	1/16W	1/10W	1/6W	$\pm 5(V)$	$100 \leq R < 5.1k$				100V	T5 T10	E-24, E-96 $-55^\circ\text{C}$ $\sim 155^\circ\text{C}$	T5 T10					
				$\pm 10(N)$	$100 \leq R < 5.1k$	$47 \leq R \leq 270k$											
				$\pm 25(P)$	$100 \leq R < 5.1k$	$47 \leq R \leq 270k$	$47 \leq R \leq 332k$	$47 \leq R \leq 1M$									
				$\pm 50(Q)$	—	—	—	$10 \leq R < 47$									
RG2012	1/10W	1/8W	1/4W	$\pm 5(V)$	$100 \leq R < 10.2k$				150V	T5 T10	E-24, E-96 $-55^\circ\text{C}$ $\sim 155^\circ\text{C}$	T5 T10					
				$\pm 10(N)$	$100 \leq R < 10.2k$	$47 \leq R \leq 475k$											
				$\pm 25(P)$	$100 \leq R < 10.2k$	$47 \leq R \leq 475k$	$47 \leq R \leq 2.7M$										
				$\pm 50(Q)$	—	—	—	$10 \leq R < 47$									
RG3216	1/8W	1/4W	—	$\pm 5(V)$	$100 \leq R < 33.2k$				200V	T5 T10	E-24, E-96 $-55^\circ\text{C}$ $\sim 155^\circ\text{C}$	T5 T10					
				$\pm 10(N)$	$100 \leq R < 33.2k$	$47 \leq R \leq 1M$											
				$\pm 25(P)$	$100 \leq R < 33.2k$	$47 \leq R \leq 1M$	$47 \leq R \leq 5.1M$										
				$\pm 50(Q)$	—	—	—	$10 \leq R < 47$									

### ◆ Dimensions



Type	Size (inch)	L	W	a	b	t
RG1005	0402	$1.00+0.1/-0.05$	$0.50 \pm 0.05$	$0.20 \pm 0.10$	$0.25 \pm 0.05$	$0.35 \pm 0.05$
RG1608	0603	$1.60 \pm 0.20$	$0.80 \pm 0.20$	$0.30 \pm 0.20$	$0.30 \pm 0.20$	$0.40 \pm 0.10$
RG2012	0805	$2.00 \pm 0.20$	$1.25 \pm 0.20$	$0.40 \pm 0.20$	$0.40 \pm 0.20$	$0.40 \pm 0.10$
RG3216	1206	$3.20 \pm 0.20$	$1.60 \pm 0.20$	$0.50 \pm 0.25$	$0.50 \pm 0.20$	$0.40 \pm 0.10$

(unit : mm)

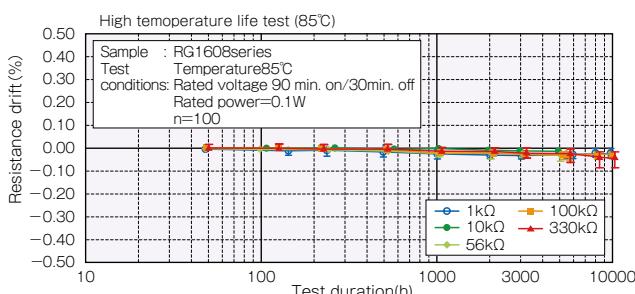
## ◆Reliability specification

Test Items	Condition (test methods)	Low		Regular		High		Typical	
		$\leq 47\Omega$	$\geq 47\Omega$						
Short time overload	2.5 x rated voltage, <sup>1</sup> 5 seconds	$\pm 0.10\%$	$\pm 0.05\%$	$\pm 0.10\%$	$\pm 0.05\%$	—	$\pm 0.10\%$	$\pm 0.01\%$	$\pm 0.01\%$
Life (biased)	70°C, rated voltage, <sup>1</sup> 90min on 30min off, 1000hours	$\pm 0.25\%$	$\pm 0.10\%$	$\pm 0.50\%$	$\pm 0.25\%$	—	$\pm 0.50\%$	$\pm 0.01\%$	$\pm 0.01\%$
High temperature high humidity	85°C, 85%RH, 1/10 of rated power, 90min on 30min off, 1000hours	$\pm 0.25\%$	$\pm 0.10\%$	$\pm 0.50\%$	$\pm 0.25\%$	—	$\pm 0.50\%$	$\pm 0.05\%$	$\pm 0.05\%$
Temperature shock	-55°C (30min) ~ 125°C (30min) 1000cycles	$\pm 0.25\%$	$\pm 0.10\%$	$\pm 0.25\%$	$\pm 0.10\%$	—	$\pm 0.10\%$	$\pm 0.01\%$	$\pm 0.01\%$
High temperature exposure	155°C, no bias, 1000hours	$\pm 0.25\%$	$\pm 0.10\%$	$\pm 0.25\%$	$\pm 0.10\%$	—	$\pm 0.10\%$	$\pm 0.01\%$	$\pm 0.01\%$
Resistance to soldering heat	260±5°C, 10 seconds (reflow)	$\pm 0.1\%$	$\pm 0.1\%$	$\pm 0.1\%$	$\pm 0.1\%$	—	$\pm 0.1\%$	$\pm 0.01\%$	$\pm 0.01\%$

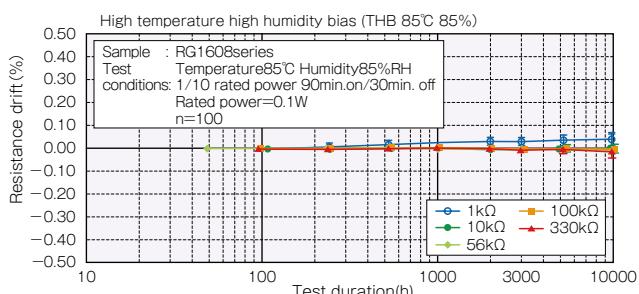
\*1 Rated voltage is given by  $E=\sqrt{R \times P}$  E= rated voltage (V), R=nominal resistance value( $\Omega$ ), P=rated power(W)  
If rated voltage exceeds maximum voltage /element, maximum voltage/element is the rated voltage.

## ◆10000 hour reliability test data

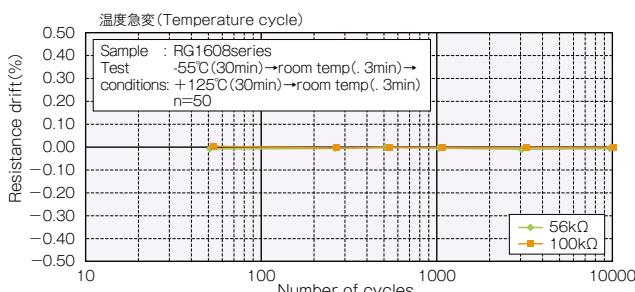
### ○Biased life test



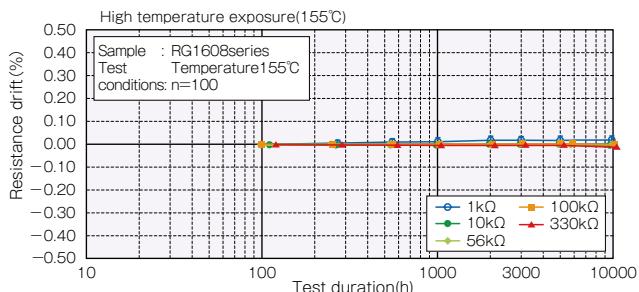
### ○High temperature high humidity (biased)



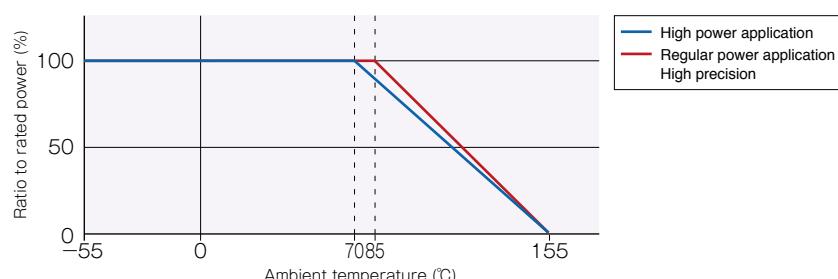
### ○Temperature shock



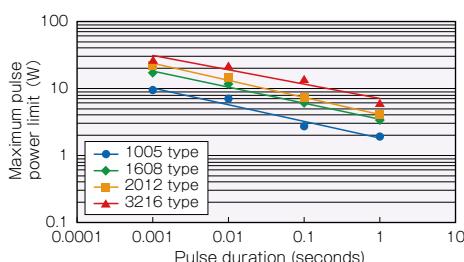
### ○High temperature exposure



## ◆Derating Curve



## ◆Maximum pulse power limit



### Test procedure

Voltage pulse is applied to the test samples mounted on the test board.

After each pulse, resistance drift is measured. Pulse voltage is increased until the drift exceeds +/-0.5%.

The power at that voltage is defined as the maximum pulse power.